Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/681,996	LEE ET AL.	
Examiner	**Art Unit**	
John M. Frink	2142	

SEARCHED			
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
inventor + text	4/23/2007	JMF
subclass + text	4/23/2007	JMF